ADJUSTABLE FLEXURE LOADING

APPARATUS FOR TESTING LONG SPAN BEAMS

TO ALL WHOM IT MAY CONCERN:

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employees of the United States Government, and residents of
employees of the United States Government, and residents of
(1) Raynham, County of Bristol, Commonwealth of Massachusetts;
and (2) Newport, County of Newport, State of Rhode Island,
and invented certain new and useful improvements entitled as
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3	ADJUSTABLE FLEXURE LOADING
4	APPARATUS FOR TESTING LONG SPAN BEAMS
5	
6	STATEMENT OF GOVERNMENT INTEREST
7	The invention described herein may be manufactured and
8	used by or for the Government of the United States of America
9	for governmental purposes without the payment of any royalties
10	thereon or therefor.
11	
12	BACKGROUND OF THE INVENTION
13	(1) Field of the Invention
14	This invention generally relates to an apparatus for
15	flexure testing long, slender shapes.
16	More particularly, the invention relates to an apparatus
17	for flexure testing long, slender shapes such as solid or
18	hollow structural beams, tubes, pipes, cylinders, and the like
19	in which a length of the specimen under test is not limited
20	and the orientation of the specimens is not limited by a
21	position of load columns on a load application device.
22	(2) Description of the Prior Art
23	The current art for flexure testing limit the specimen
24	length to an inside distance between load columns of a load
25	application device and require specimens to be oriented within
26	the plane defined by the load columns.

- 1 The following patents, for example, disclose flexure testing,
- 2 but do not disclose flexure testing in which a specimen is
- 3 aligned perpendicularly to the load column plane such that no
- 4 restriction is imposed on specimen length.
- 5 Specifically, Glassmeyer (United States Patent No.
- 6 3,898,873) discloses an intermodel cargo container bottom lift
- 7 tested by means of a test fixture including adjustable
- 8 supports which are connected to the lower corner fittings to
- 9 maintain the container in a raised position free of a
- 10 supporting surface. The upper corner fittings are first
- 11 connected to a suitable hoisting device and upon lifting are
- 12 placed in tension. The lower corner fitting lifting
- 13 capability of the container is then tested by releasing the
- 14 tension in the cables, the bottom lift test fixtures being
- 15 placed in compression.
- 16 Hayashi (United States Patent No. 4,590,900) discloses a
- 17 valve supporting arrangement of an internal combustion engine.
- 18 The upper retainer is for retaining an upper portion of a
- 19 valve spring shaped like a perforated spinning top and is
- 20 axially dividable into two identical elements which are
- 21 coaxially disposed about the upper portion of the valve stem
- 22 when assuming its operative condition. The retainer has, when
- 23 assuming the operative position, a configuration which
- 24 comprises a collar portion which is sized to be coaxially
- 25 disposed within an upper portion of the valve spring, an
- 26 annular flange portion extending radially outward from the
- 27 upper end of the collar portion and engaging with the upper

- 1 end of the valve spring, and means for achieving a spline
- 2 connection between the central portion of the retainer and the
- 3 upper portion of the valve stem.
- 4 Maciejczak (United States Patent No. 4,789,947)
- 5 discloses, in conjunction with an unmanned, remotely
- 6 controllable apparatus for inspecting, testing and viewing and
- 7 for examination and evaluation of the general condition, state
- 8 of repair, and of the quality of fabrication of mechanical
- 9 structures including bridges, an assembly including a guide
- 10 track carried by a space frame fastened to extend transversely
- 11 of a bridge or other structure at an underside thereof. The
- 12 track supports a carrier adapted for transporting, viewing,
- 13 examining, treating and testing apparatus for controlled
- 14 movement and manipulation of the apparatus along a path
- 15 delineated by the guide track. In a preferred embodiment of
- 16 the invention the carrier supports one or more turntables and
- 17 one or more articulated arms and linked arm assemblies at
- 18 remote ends of which selectable viewing and testing devices
- 19 are attachable. The space frame itself may be moved lineally
- 20 along the bridge, on an underside thereof so that through the
- 21 combination of the transversely moving carrier and the
- 22 lineally movable space frame, an entire aerial zone may be
- 23 traversed.
- 24 Strong (United States Patent No. 5,345,826) discloses a
- 25 static load tester that provides tensile testing of plated
- 26 test specimens to detect hydrogen embrittlement damage from
- 27 plating processes. The functional components of the device

- are centrally aligned within a channel of an I-beam frame. A
- 2 load cell and electronic readout provide the user with a
- 3 measure of the tensile force applied to up to eight test
- 4 specimens mounted end to end in a tester. Tension is applied
- 5 to the specimens through use of a simple threaded rod and nut
- 6 load application system at the base of the device. A static
- 7 load tester may be incorporated into each channel of the I-
- 8 beam frame, thereby providing a double testing unit.
- 9 Additionally, a series of I-beam frame tester configurations
- 10 may be incorporated into one multiple testing unit. Each
- 11 multiple testing unit has a number of static load testers
- 12 equal to double the number of I-beam frames mounted into the
- 13 unit. The tension applied to any individual tester in a
- 14 multiple testing unit may be displayed on a single electronic
- 15 readout through use of a switch box coupled between the
- 16 individual testers and the readout.
- Diaz et al. (United States Patent No. 5,386,442)
- 18 discloses an apparatus and a method for measuring and
- 19 controlling the crack growth rate within a double cantilever
- 20 beam type test specimen. The arms of the test specimen are
- 21 fitted with a pressure-actuated bellows to induce a
- 22 predetermined load and with a sensing assembly to provide
- 23 feedback on the amount of beam displacement resulting from the
- 24 application of that load. In this manner, a loaded test
- 25 specimen may be remotely mounted and adjusted inside the
- 26 reactor pressure vessel or piping of a nuclear reactor in
- 27 order to maintain a stress intensity which is constant or

- 1 which varies in a predetermined manner for inducing stress
- 2 corrosion cracking or corrosion fatigue in the specimen.
- 3 Tucchio (United States Patent No. 5,448,918) discloses a
- 4 biaxial compression testing device formed by two modified
- 5 beams joined together to form an X-shape with the support
- 6 structure, such as webs and upper flanges, removed in the
- 7 region of the X intersection, thereby leaving a rectangular
- 8 opening. The rectangular opening has dimensions slightly
- 9 greater than the widths of the beams and is open from the
- 10 upper surfaces downward to the lower surfaces which are joined
- 11 together forming an X-configuration. This configuration has a
- 12 flexing characteristic in the direction perpendicular to the
- 13 plane of the joined beams. A test specimen support plate is
- 14 attached to the underside of one of the upper surfaces and is
- 15 located so as to slide below the opposing upper surface during
- 16 flexing of the X-beam assembly. Each beam is supported by a
- 17 roller pin. Additional roller pins are located on the
- 18 specimen support plate between each beam upper flange and a
- 19 specimen to be tested. The single actuating force is applied
- 20 to cause the X-beams to flex into a concave shape thereby
- 21 applying a part of the actuating force axially along each
- 22 beam. The configuration provides a force transfer assembly
- 23 which is actuated by a single load force, but provides a
- 24 biaxial load to the test specimen.
- 25 Starostovic, Jr. (United States Patent No. 5,699,274)
- 26 discloses a performance testing system, i.e., performance of a
- 27 material under a load concentrated in a single area. The

system is computerized and automatically applies a load to a panel to be tested, reads and records deflection of the panel without operator involvement, and provides a printed test Simonelli et al. (United States Patent No. 5,913,246) discloses a machine for the cyclic load testing in tension, compression, torsion, shear, or any combination thereof of any 2 One of a number of different sizes, types and configurations 3 report. of test specimens at a fixed or adjustable predetermined load 4 and cycle rate and comprising a machine frame in which is 5 mounted a drive shaft, any number of intermediate shafts as 6 required, and a camshaft or crankshaft. At the workstation of 7 the machine, appropriate fixtures and tooling are either fixed, rotating, or in motion, as required to conduct the 9 particular test to be performed. When the test specimen is to 10 be in motion, the motion may be derived from a driving source separate from the primary mover or camehaft, for instance, but 13 not limited to an independent motor or cylinder. of motion may also be taken through a drive train or any 14 suitable means from the same driving source as the camshaft or 15 from the camshaft itself or from any other moving member in 16 the system. A motion is ultimately imparted to drive the test A motion is ultimately imparted to drive the test 17 specimen holder, thereby setting the test specimen in motion. 18 Miller et al. (United States patent No. 6,042,315) 19 20 discloses a fastener body comprising a head and a shank fabricated from a composite material. The head has at least 21 one gide which extends beyond the side of the shank and has 22 23 24 25 26 27

- 1 two other sides coplanar with the shank. A fastener for
- 2 engaging a liner has perpendicular lengthwise and widthwise
- 3 reference axes and a head and a shank, with the shank
- 4 extending in a first lengthwise direction away from the head,
- 5 the head further having at least one extension that extends in
- 6 the widthwise direction beyond the shank for engaging the
- 7 liner, wherein substantially all lengthwise directed load
- 8 components transmitted from the liner to the head are
- 9 transmitted through the extension.
- 10 Starostovic (United States patent No. 5,699,274)
- 11 discloses a performance testing system for woodbased panels.
- 12 The testing includes performance of a material under a load
- 13 concentrated in a single area, performance of edge support
- 14 systems under a concentrated load and performance of a
- 15 material under static bending conditions. The system is
- 16 computerized and automatically applies a load to a panel to be
- 17 tested, reads and records deflection of the panel without
- 18 operator involvement, and provides a printed test report.
- 19 Zhou (United States Patent No. 6,216,531) discloses an
- 20 adapter for use in the testing of shear strength of an
- 21 adhesive as applied to a test specimen. The adapter has a
- 22 structure that permits it to be used on testing machines
- 23 either in a tension or in a compression mode. The adapter as
- 24 a testing tool includes a pair of coacting force blocks which
- 25 slidably engage each other and move relative to each other.
- 26 Each such force block has a central opening into which a test
- 27 specimen may be inserted. The openings in each of the force

- 1 blocks engage a different one of the two test coupons that
- 2 make up a testing specimen. The force blocks further have
- 3 bearing surfaces that oppose each other so that they may
- 4 engage the like opposing ends of the test specimen.
- 5 It should be understood that the present invention would
- 6 in fact enhance the functionality of the above patents by
- 7 providing an adjustable apparatus for supporting long span
- 8 beams in a flexure testing machine regardless of their length
- 9 or orientation.

10

11 SUMMARY OF THE INVENTION

- Accordingly, it is a general purpose and primary object
- 13 of this invention to provide an adjustable apparatus for
- 14 supporting long span beams.
- 15 It is a further object of this invention to provide an
- 16 adjustable apparatus for supporting long span beams in a
- 17 flexure testing machine.
- 18 It is a still further object of this invention to provide
- 19 an adjustable apparatus for supporting a long span beam
- 20 specimen in an orientation normal to that of the operating
- 21 structure on a load application device.
- It is a still further object of the invention to provide
- 23 an adjustable apparatus for supporting a long span beam
- 24 specimen that is simple to operate and easily implemented into
- 25 existing load testing devices.
- To obtain the objects described, there is disclosed an
- 27 adjustable apparatus for supporting a long span beam specimen

- 1 in a flexure test by a load application device. The apparatus
- 2 includes an upper support structure including an elongated
- 3 support beam, at least one support bracket adjustably
- 4 mountable along a longitudinal span thereof, and a saddle
- 5 member selectively pivotally mounted in the at least one upper
- 6 support bracket for engaging with a specimen under test. The
- 7 upper support structure is positioned normal to the load
- 8 application device and a lower support structure is positioned
- 9 parallel and co-planar to the upper support structure. The
- 10 lower support structure includes an elongated support beam, at
- 11 least one spacing member adjustably mounted along a
- 12 longitudinal span thereof, a lower support bracket adjustably
- 13 mounted along a longitudinal span of the spacing member, and a
- 14 saddle member selectively pivotally mounted in the lower
- 15 support bracket for engaging with a specimen under test.

16

17 BRIEF DESCRIPTION OF THE DRAWINGS

- The appended claims particularly point out and distinctly
- 19 claim the subject matter of this invention. The various
- 20 objects, advantages and novel features of this invention will
- 21 be more fully apparent from a reading of the following
- 22 detailed description in conjunction with the accompanying
- 23 drawings in which like reference numerals refer to like parts,
- 24 and in which:
- FIG. 1 is a perspective view of a specimen supporting
- 26 apparatus in a characteristic flexure testing environment
- 27 according to a preferred embodiment of the present invention;

- 1 FIG. 2 is an exploded bottom perspective view of a top
- 2 fixture of the specimen supporting apparatus shown in FIG. 1;
- 3 and
- 4 FIG. 3 is an exploded top perspective view of a bottom
- 5 fixture of the specimen supporting apparatus shown in FIG. 1.

6

7 DESCRIPTION OF THE PREFERRED EMBODIMENT

- 8 In general, the present invention is directed to a
- 9 specimen supporting apparatus generally intended for use in
- 10 flexure testing of long slender shapes (such as, but not
- 11 limited to, solid or hollow structural beams, tubes, pipes,
- 12 cylinders, and the like) in which the load-deflection or
- 13 stress-strain characteristics of a specimen being tested are
- 14 sought.
- Referring first to FIG. 1, there is shown a perspective
- 16 view of a specimen supporting apparatus 10 according to the
- 17 present invention and in a working environment of a typical
- 18 flexure testing device.
- The specimen supporting apparatus 10 includes an upper
- 20 support structure 11 and a lower support structure 12. These
- 21 upper and lower support structures, 11, 12, are each formed in
- 22 a basic I-beam shape. For the purposes of the present design
- 23 shown, these upper 11 and lower 12 support structures are
- 24 formed of aluminum 6061-T6 W6x25 I-beams, however, other
- 25 materials known to those skilled in the art may be used.
- Referring still to FIG. 1, it can be seen that the upper
- 27 and lower support structures 11, 12 are positioned parallel to

- 1 and co-planar with each other. The upper support structure 11
- 2 is shown mounted transverse to a moving upper platen 100 of
- 3 the testing device and the lower support structure 12 is shown
- 4 mounted transverse to a lower stationary platen 102 of the
- 5 testing device. The upper platen 100 is spaced from the lower
- 6 platen 102 by a pair of hydraulically operated columns 104 as
- 7 is known in the art such that the upper platen 100 is
- 8 adjustably positioned with a testing force relative to the
- 9 lower platen 102. Operation of the testing device is omitted
- 10 for the sake of brevity and as having no part of the subject
- 11 invention other than explanation of a suggested environmental
- 12 use of the specimen supporting apparatus 10 being described.
- 13 Additional details of the upper support structure 11 and
- 14 the lower support structure 12 of the specimen support device
- 15 10 are shown in each of FIGS. 2 and 3, respectively and are
- 16 intended to be referenced in connection with FIG. 1 and the
- 17 following description.
- 18 The upper support structure 11 is shown in FIG. 2 in an
- 19 inverted and exploded perspective view in order to better
- 20 understand the parts thereof. Specifically, the upper support
- 21 structure 11 is shown in an I-beam shape with opposing end
- 22 plates 14, 16 and an inner wall 18 perpendicular to and
- 23 spacing apart the end plates 14, 16, thus defining the "I"
- 24 shape of the structure. A plurality of paired and spaced
- 25 apertures 44 are formed through one of the end plates 16 along
- 26 an entire length thereof.

- 1 At least one support bracket 20 is mounted to the
- 2 apertured end plate 16. The support bracket 20 includes a
- 3 base portion 22 for surface contact with the apertured end
- 4 plate 16 and side walls 24 projecting from opposing sides of
- 5 the base portion 22 and away from the fixture 10. The base
- 6 portion 22 of the support bracket 20 has apertures 26 formed
- 7 therein which are aligned to mate with corresponding apertures
- 8 44 formed in the end plate 16 of the upper support structure
- 9 11. The connection of the support bracket 20 to the end plate
- 10 16 is with suitable fixing means such as screws, bolts, or the
- 11 like.
- 12 Each of the projecting side walls 24 of the support
- 13 bracket 20 include a centered slot 28 at the distal end
- 14 thereof and a pair of apertures 30, one to each side of the
- 15 centered slot 28. A saddle member 32 includes a saddle
- 16 portion 34 and opposing pins 36 extending from outer ends of
- 17 the saddle portion 34 such that the pins 36 seat into the
- 18 centered slots 28 of the support bracket 20 with the saddle
- 19 portion 34 fit between the side walls 24 and enabling pivotal
- 20 rotation of the saddle member 32 with respect to the support
- 21 bracket 20. Each pin 36 is secured in the centered slots 28
- 22 with a slotted fixing plate 38. The slotted fixing plate 38
- 23 is rectangular and includes a slot 40 formed in an edge
- 24 thereof with an aperture 42 on each side of the slot 40. The
- 25 slot 40 slides over the pin 36 of the saddle member 32 and the
- 26 apertures 42 align with the apertures 30 of the side walls 24
- 27 for securement by any suitable means such as a screw, welding

- 1 or the like. This securement enables movement of the saddle
- 2 member 32 without separation from the support bracket 20.
- 3 Still referring to the upper support structure 11, if a
- 4 single support bracket 20 is utilized, then it is positioned
- 5 at the mid span of the upper support structure 11. This
- 6 arrangement enables a three-point flexure loading in
- 7 connection with the lower support structure 12.
- 8 If two support brackets 20 are utilized, then each
- 9 support bracket 20 is equidistantly positioned to each other
- 10 from a mid-point of the upper support structure 11 according
- 11 to the matching paired aperture patterns 44 between the upper
- 12 support structure 11 and the support brackets 20. This
- 13 arrangement enables a four-point flexure loading in connection
- 14 with the lower support structure 12. The upper support
- 15 bracket 20, in whatever number utilized, is attached to the
- 16 apertured end plate 16 of the upper support structure 11 with
- 17 bolts or other suitable fastening means (not specifically
- 18 shown for simplicity). It should be understood, however, that
- 19 these support brackets 20 are movable along the length of the
- 20 upper support structure 11 and should therefore be fixed with
- 21 secure, yet removable means.
- Referring now to details of the lower support structure
- 23 12, the lower support structure 12 is also shown in an I-beam
- 24 shape with opposing end plates 50, 52 and an inner wall 54
- 25 perpendicular to and spacing apart the end plates 50, 52, thus
- 26 defining the "I" shape of the structure. A plurality of
- 27 paired and spaced apertures 46 are formed through one of the

- 1 end plates 52 along an entire length thereof. These paired
- 2 and spaced apertures 46 are in the end plate 52 which faces
- 3 the similarly formed apertures 44 of the upper support
- 4 structure 11.
- 5 At least one offset member 56 is provided in connection
- 6 with the lower support structure 12. This offset member 56 is
- 7 bolted to the lower support structure 12 using a paired
- 8 aperture pattern 58 that matches the spacing of the paired
- 9 apertures 46 in the end plate 52 of the lower structure 12.
- 10 The offset member 56 provides an offset clearance between a
- 11 specimen under test and the lower support structure 12 such
- 12 that the specimen under flexure loads will not deflect to the
- 13 point where contact between the specimen and lower support
- 14 structure 12 is made.
- 15 The offset member 56 is structurally similar in shape to
- 16 the lower support structure 12 in that it is of an I-beam
- 17 shape. The I-beam shape of the offset member 56 includes
- 18 opposing end plates 60, 62, each having paired aperture
- 19 patterns 58, and an inner wall 64 perpendicular to and spacing
- 20 apart the end plates 60, 62. The offset member 56 is
- 21 substantially shorter than the lower support structure 12,
- 22 spanning only approximately three sets of paired apertures 46
- 23 thereon.
- 24 A slider 66 is adjustably positioned with respect to the
- 25 offset member 56. The slider 66 includes a support leg 68
- 26 with a T-shaped base 70 and a support bracket 72 at an end
- 27 opposing the T-shaped base 70. The support bracket 72

- 1 includes a base portion 72a integrally connected to the
- 2 support leg 68 and side walls 72b projecting from opposing
- 3 sides of the base portion 72a and away from the offset member
- 4 56.
- 5 Each of the projecting side walls 72b of the support
- 6 bracket 72 include a centered slot 74 at the distal end
- 7 thereof. A saddle member 76 is seated in the support bracket
- 8 72 and includes a saddle portion 78 and opposing pins 80
- 9 extending from outer ends of the saddle portion 78 such that
- 10 the pins 80 seat into the centered slots 74 of the support
- 11 bracket 72 with the saddle portion between the side walls 72b
- 12 and enabling pivotal rotation of the saddle member 76 with
- 13 respect to the support bracket 72. Unlike the saddle member
- 14 32 of the upper support bracket 20, the pins 80 of the saddle
- 15 member 76 in the lower support bracket 72 need not be secured
- 16 in the centered slots 74. This is because the weight of the
- 17 specimen to be tested will secure the saddle member 76 without
- 18 separation from the support bracket 72.
- 19 A series of spacers 82 and overlying fixing plates 84 are
- 20 attached to that end wall 62 of the offset member 56 which is
- 21 not secured to the apertured end wall 52 of the lower support
- 22 fixture 12. The spacers 82 and fixing plates 84 create a
- 23 slide positioning mechanism securing the T-shaped base 70 of
- 24 the slider 66 to the offset member 56 through paired apertures
- 25 86, 88 of the spacers and fixing plates, respectively. These
- 26 apertures 86, 88 align with corresponding apertures 58 of the
- 27 spacer 56. This provides a finer spacing control for

- 1 adjustments less than the pitch distance between the matching
- 2 paired apertures 58 in the offset member 56 and those
- 3 apertures 46 in the lower support structure 12.
- 4 Due to the arrangement of spacers 82 and overlying fixing
- 5 plates 84, there are two different ways to adjust the distance
- 6 between saddles 76 mounted at opposite ends of the lower
- 7 support structure 12.
- 8 In a first distance adjustment, a coarse adjustment can
- 9 be made according to the selection of the bolt hole groups 26
- 10 used to secure the upper brackets 20 to the upper support
- 11 structure 11 and, likewise, the paired apertures 58 used to
- 12 secure the offset members 56 to the lower support structure
- **13** 12.
- 14 In a second distance adjustment, a finer adjustment
- 15 mechanism is included in between the offset member 56 and the
- 16 slider 66. The series of spacers 82 and fixing plates 84
- 17 clamp the slider 66 to the offset member 56. This provides
- 18 spacing control that is less than the pitch distance between
- 19 the matching aperture patterns 58 in the offset member 56 and
- 20 the paired apertures 46 in the lower support structure 12.
- During operation and as shown in FIG. 1, the lower
- 22 support structure 12 and the attached components as described
- 23 are positioned normal to the load column plane of the columns
- 24 104 of the flexure testing device and centered on the
- 25 stationary platen 102 (assumed to be the bottom platen) of the
- 26 flexure testing device. It is desired that equal lengths of
- 27 the end plates 50, 52 of the lower support structure 12

- 1 overhang the front and rear sides of the plane defined by the
- 2 load columns 104. Similarly, the upper support structure 11
- 3 and attached components are positioned normal to the load
- 4 column plane and centered on the moving platen 100 (assumed to
- 5 be the top platen) of the flexure testing device. The upper
- 6 and lower support structures 11, 12 are checked to be co-
- 7 planar to each other and the complete assembly is checked to
- 8 be normal to the load column plane.
- 9 The specimen is secured in the saddles 76 of the lower
- 10 support structure 12 and the testing device applies the load
- 11 by moving the upper support structure 11 downward such that
- 12 the upper saddles 32 are pushing down on the specimen under
- 13 test and the lower saddles 76 react the load upwards. The
- 14 saddles 32, 76 will rotate as the specimen deforms. This is
- 15 the follower-loading mode.
- To utilize the non-follower-loading mode, locking pins
- 17 (not shown) are placed through corresponding holes in the side
- walls 72b of the slider 66 and the pins 80 of the saddles 76.
- 19 The same is done for the apertures 30 in the side walls 24 of
- 20 the upper bracket 20 and the pins 36 of the saddles 32.
- It should be understood that the subject specimen
- 22 supporting apparatus 10 is known to accommodate 96 inches long
- 23 specimens, however, there is no restriction for obtaining
- 24 specimen lengths beyond 96 inches. Both coarse and fine
- 25 adjustment mechanisms are included for setting the spans
- 26 between load and support points. A full range of load and
- 27 support point positions is thereby provided.

- 1 A rotational locking mechanism such as a pin is included
- 2 in the saddle design to enable the user to test in either
- 3 follower or non-follower loading modes. In a follower-loading
- 4 mode, the saddles rotate as the specimen deforms since the
- 5 resulting force vector remains in the same direction relative
- 6 to the localized region of the specimen to which it is applied
- 7 as the specimen deforms globally. In a non-follower loading
- 8 mode, the force vector remains in the same global direction at
- 9 all times and does not change directions as the specimen
- 10 deforms. The non-follower mode will transfer the load from
- 11 the saddle outer edge rather than along the saddle surface
- 12 are. Accordingly, to operate in a non-follower monde, locking
- 13 pins (not specifically shown) are inserted through
- 14 corresponding holes in the sides of the bottom slider and the
- 15 axles of the lower saddles, thereby securing them against
- 16 rotation. The same is done for the holes in the sides of the
- 17 top support and the axles of the upper saddles.
- 18 Other additional benefits are realized when coupling the
- 19 specimen supporting apparatus 10 to a flexure testing device.
- 20 These include, but are not limited to, testing the specimen in
- 21 a load-controlled mode such as a constant loading rate of 10
- 22 pounds per minute; and testing the specimen in a displacement-
- 23 controlled mode such as a constant displacement rate of 1.0
- 24 inch per minute. These types of tests are known in the art
- 25 and are included as examples of the uses of the present
- 26 invention.

- There are several contemplated singular or combined
- 2 alternatives to the described subject disclosure, and these
- 3 are intended to be included within the scope of the invention,
- 4 although the invention is not limited to these suggested
- 5 alternatives.
- 6 In a first alternative, a T-shaped slotted block could be
- 7 used as an alternative to the slide positioning mechanism of
- 8 spacers 82 and fixing plates 84.
- 9 In a second alternative, the saddles 32 may be installed
- 10 within the upper bracket 20 and the saddle 76 may be installed
- 11 at the bottom sliders using bearings, needles, rollers, or the
- 12 like to reduce rotational friction forces when using the
- 13 follower loading mode.
- 14 Alternative structural shapes may be used for the various
- 15 components, such as box beam shapes for the upper and lower
- 16 support structures 11, 12 rather than I-beam shapes.
- 17 The slide positioning mechanism of spacers 82 and fixing
- 18 plates 84 shown in connection with the lower support structure
- 19 12 may also be implemented in connection with the upper
- 20 support structure 11.
- In view of the above detailed description, it is
- 22 anticipated that the invention herein will have far reaching
- 23 applications other than those of flexure testing of elongated
- 24 materials.
- This invention has been disclosed in terms of certain
- 26 embodiments. It will be apparent that many modifications can
- 27 be made to the disclosed apparatus without departing from the

- 1 invention. Therefore, it is the intent of the appended claims
- 2 to cover all such variations and modifications as come within
- 3 the true spirit and scope of this invention.